

P29281.A01



IFW

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant : Syuhei AKUTAGAWA

Group Art Unit : Not Yet Assigned

Appl. No. : 10/567,910

(U.S. National Stage of PCT/JP2005/006907)

I.A. Filed : April 8, 2005

Examiner : Not Yet Assigned

For : CONNECTOR

INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents
U.S. Patent and Trademark Office
Customer Service Window, Mail Stop AMENDMENT
Randolph Building
401 Dulany Street
Alexandria, VA 22314

Sir :

In accordance with the duty of disclosure under 37 C.F.R. § 1.56 and §§1.97-1.98, Applicant hereby brings the following information to the attention of the Examiner in charge of the above-identified application, which includes information cited and discussed in the specification and the International Search Report issued in connection with International Patent Application No. PCT/JP2005/006907, of which the present application is the U.S. National Stage Application. A copy of the International Search Report was enclosed with the papers when entering the U.S. National Stage on February 10, 2006. The Examiner is invited to review these materials to inspect the relevance indicated during international examination with respect to the documents cited therein. The following is a list of the documents cited in the above-noted documents:

Japanese Laid-open Patent Publication No. 2001-223057, together with an English language abstract of the same. Applicant notes that this document is cited and discussed on page 1 of the specification;

Japanese Laid-open Patent Publication No. 2000-215948, together with an English language abstract of the same; and

Japanese Laid-open Patent Publication No. HEI 2-119075, together with an English language abstract of the same.

Applicant also call to the Examiner's attention the U.S. Patent No. 6,821,158.

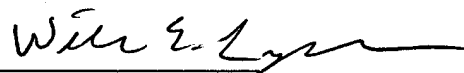
Further to 37 C.F.R. §1.98 (a)(2)(ii), a copy of the U.S. patent is not enclosed herewith. However, if a copy is needed, the Examiner is respectfully requested to contact the undersigned.

Applicant respectfully requests that the Examiner consider the above material and cite the same. Copies of the above-noted foreign documents are attached hereto and all of the above-noted documents are listed on the attached PTO-1449 Form. The Examiner is requested to initial the appropriate spaces on the attached Form and to return a copy of the completed Form to Applicant with the next official communication in the present application.

Applicant notes that an Office Action on the merits has not issued in the present application, and thus no fee is believed necessary to ensure consideration of the submitted material

Should the Examiner have any questions, the Examiner is invited to
contact the undersigned at the below-listed telephone number.

Respectfully Submitted,
Syuhei AKUTAGAWA



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May 24, 2006
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FORM PTO-1449

U.S. Department of Commerce
Patent and Trademark OfficeAtty. Docket No.
P29281Application No.
10/567,910INFORMATION DISCLOSURE STATEMENT
BY APPLICANT
(Use several sheets if necessary)Applicant
Syuhei AKUTAGAWAFiling Date
I.A. Filed April 8, 2005Group
Not Yet Assigned

U.S. PATENT DOCUMENTS

EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
	6 8 2 1 1 5 8	11/23/04	IIDA et al.			

FOREIGN PATENT DOCUMENTS

	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO
2001	- 2 2 3 0 5 7	08/17/01	JAPAN			
2000	- 2 1 5 9 4 8	08/04/00	JAPAN			
2	- 1 1 9 0 7 5	05/07/90	JAPAN			

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

1	English Language Abstract of JP 2001-223057.
2	English Language Abstract of JP 2000-215948.
3	English Language Abstract of JP 2-119075.

EXAMINER

DATE CONSIDERED

*EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.